

SEMICONDUCTOR®

KST05/06

Driver Transistor

- Collector-Emitter Voltage: V_{CEO} = KST05: 60V
- KST06: 80V
- Collector Power Dissipation: P_C (max) = 350mW
- Complement to KST55/56



1. Base 2. Emitter 3. Collector

NPN Epitaxial Silicon Transistor

Absolute Maximum Ratings Ta=25°C unless otherwise noted

Symbol	Parameter	Value	Units
V _{CBO}	Collecto-Base Voltage		
	: KST05	60	V
	: KST06	80	V
V _{CEO}	Collector-Emitter Voltage		
	: KST05	60	V
	: KST06	80	V
V _{EBO}	Emitter-Base Voltage	4	V
I _C	Collector Current	500	mA
P _C	Collector Power Dissipation	350	mW
P _C T _{STG}	Storage Temperature	150	°C
R _{TH} (j-a)	Thermal Resistance junction to Ambient	357	°C/W

Electrical Characteristics Ta=25°C unless otherwise noted

Symbol	Parameter	Test Condition	Min.	Max.	Units
BV _{CEO}	* Collector-Emitter Breakdown Voltage : KST05	I _C =1mA, I _B =0	60		v
	: KST06	IC-1117, IB-0	80		v
BV _{EBO}	Emitter-Base Breakdown Voltage	I _E =100μA, I _C =0	4		V
I _{CBO}	Collector Cut-off Current	V _{CB} =60V, I _E =0			
	: KST05	V _{CB} =80V, I _E =0		0.1	μA
	: KST06			0.1	μΑ
I _{CEO}	Collector Cut-off Current	V _{CE} =60V, I _B =0		0.1	μΑ
h _{FE}	DC Current Gain	V _{CE} =1V, I _C =10mA	50		
		$V_{CE}=1V$, $I_{C}=100mA$	50		
V _{CE} (sat)	Collector-Emitter Saturation Voltage	I _C =100mA, I _B =10mA		0.25	V
V _{BE} (on)	Base-Emitter On Voltage	V _{CE} =1V, I _C =100mA		1.2	V
f _T	Current Gain Bandwidth Product	V _{CE} =2V, I _C =100mA, f=100MHz	100		MHz

* Pulse Test: PW≤300µs, Duty Cycle≤2%

Marking Code

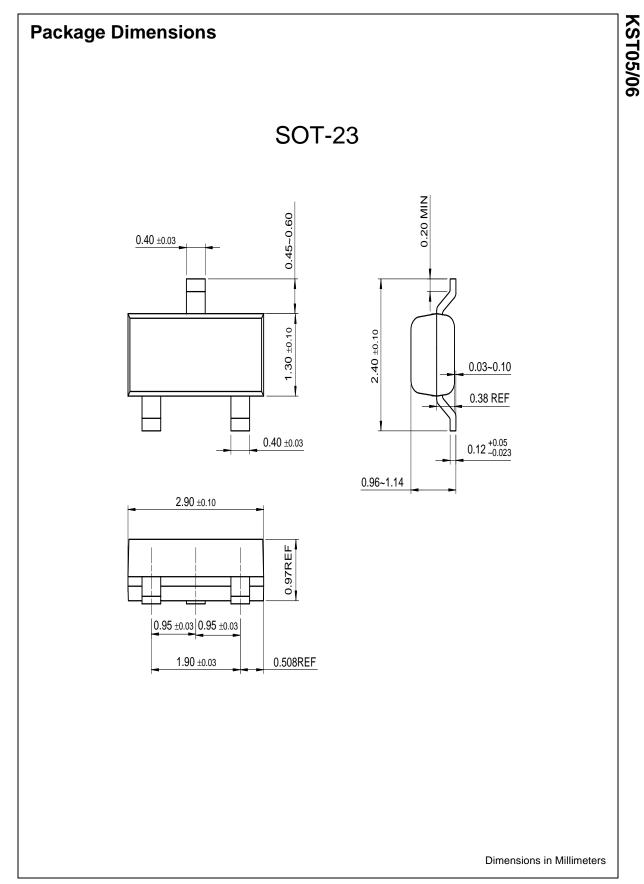
Туре	KST05	KST06
Mark	1H	1G

Marking

©2002 Fairchild Semiconductor Corporation

Rev. A2, November 2002

KST05/06



©2002 Fairchild Semiconductor Corporation

TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

Datasheet Identification	Product Status	Definition
Advance Information	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
No Identification Needed	Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
Obsolete	Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.

©2002 Fairchild Semiconductor Corporation